# **VTS Process Photodiodes**

**VTS 86** 

### PRODUCT DESCRIPTION

This series of planar, P on N, large area silicon photodiodes is characterized for use in the photovoltaic (unbiased) mode. Their excellent speed and broadband sensitivity makes them ideal for detecting light from a variety of sources such as LEDs, IREDs, flashtubes, incandescent lamps, lasers, etc. Improved shunt resistance minimizes amplifier offset and drift in high gain systems. The solderable contact system on these photodiodes provides a cost effective design solution for many applications.

#### **ABSOLUTE MAXIMUM RATINGS**

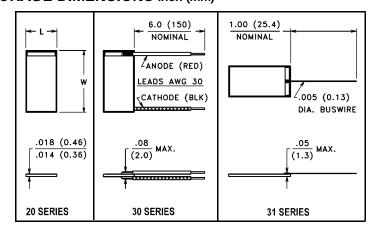
Storage Temperature:

-40°C to 150°C Series 20, 31 -40°C to 105°C Series 30

Operating Temperature:

-40°C to 125°C Series 20, 31 -40°C to 105°C Series 30

### PACKAGE DIMENSIONS inch (mm)



### CASE 44B ANODE (ACTIVE) SURFACE SHOWN CATHODE IS BACKSIDE

DIMENSIONS	VTS86
L	.100 (2.54)
W	.200 (5.08)
ACTIVE AREA	.015 <sup>2</sup> (10 <sup>2</sup> )

## ELECTRO-OPTICAL CHARACTERISTICS @ 25°C (See also VTS curves, page 67)

SYMBOL	CHARACTERISTIC	TEST CONDITIONS	VTS86			UNITS
			Min.	Тур.	Max.	UINITS
$I_{SC}$	Short Circuit Current	H = 1000 lux, 2850 K	60	80		μΑ
TC I <sub>SC</sub>	I <sub>SC</sub> Temperature Coefficient	H = 1000 Lux, 2850 K		.20		%/°C
I <sub>D</sub>	Dark Current	H = 0, VR = 100 mV		10	100	nA
TC I <sub>D</sub>	ID Temp. Coefficient	H = 0, VR = 100 mV		+11		%/°C
R <sub>SH</sub>	Shunt Resistance	H = 0, VR = 10 mV		6.0		MΩ
СЈ	Junction Capacitance	H = 0, V = 0 V, 1 MHz		0.25		nF
S <sub>R</sub>	Sensitivity	@ 400 nm	.18	0.20		A/W
Re	Responsivity	400 nm, 0.18 A/W		0.02		A/(W/cm <sup>2</sup> )
TC V <sub>OC</sub>	Sensitivity @ Peak	925 nm		0.60		A/W
t <sub>R</sub> /t <sub>F</sub>	Response Time @ 1 k $\Omega$ Load	VR = 1 V, 830 nm		0.75		µsec
V <sub>OC</sub>	Open Circuit Voltage	H = 1000 Lux, 2850 K	0.25	0.45		Volts
TC V <sub>OC</sub>	V <sub>OC</sub> Temperature Coefficient	H = 1000 Lux, 2850 K		-2.6		mV/°C